

Search Notes

Application/Control No.

10/539,334

Examiner

Suchin Parihar

Applicant(s)/Patent under
Reexamination

ARTHANARI ET AL.

Art Unit

2825

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 716 | 13 | 5/16/2006 | SP |
| 257 | 208 | 5/16/2006 | SP |
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INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|-----------------------------------------------------------------------------------------------|-----------|------|
| EAST Text Search US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM-TDB (See Attached History) | 5/16/2006 | SP |
| IEEE Xplore Search (See Search History) | 5/16/2006 | SP |
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